

# High Speed, Dual Channel, 6A, Power MOSFET Driver with Enable Inputs

## ISL89163, ISL89164, ISL89165

The ISL89163, ISL89164, and ISL89165 are high-speed, 6A, dual channel MOSFET drivers with enable inputs. These parts are identical to the ISL89160, ISL89161, ISL89162 drivers but with an added enable input for each channel occupying NC pins 1 and 8 of the ISL89160, ISL89161, ISL89162.

Precision thresholds on all logic inputs allow the use of external RC circuits to generate accurate and stable time delays on both the main channel inputs, INA and INB, and the enable inputs, ENA and ENB. The precision delays capable of these precise logic threshold makes these parts very useful for dead time control and synchronous rectifiers. Note that the ENable and INput logic inputs can be interchanged for alternate logic implementations.

Three input logic thresholds are available: 3.3V (CMOS), 5.0V (CMOS or TTL compatible), and CMOS thresholds that are proportional to VDD.

At high switching frequencies, these MOSFET drivers use very little internal bias currents. Separate, non-overlapping drive circuits are used to drive each CMOS output FET to prevent shoot-thru currents in the output stage.

The under voltage lockout (UV) insures that driver outputs remain off (low) during turn-on until VDD is sufficiently high for correct logic control. This prevents unexpected glitches when VDD is being turn-on or turn-off.

## Features

- Dual output, 6A peak current (sink and source)
- Dual AND-ed input logic, (**IN**put and **EN**able)
- Typical ON-resistance  $< 1\Omega$
- Specified Miller plateau drive currents
- Very low thermal impedance ( $\theta_{JC} = 3^{\circ}\text{C/W}$ )
- Input logic levels for 3.3V CMOS, 5V CMOS, TTL and Logic levels proportional to VDD
- Hysteretic logic inputs for high noise immunity
- Precision threshold inputs for time delays with external RC components
- ~ 20ns rise and fall time driving a 10nF load.
- Low operating bias currents

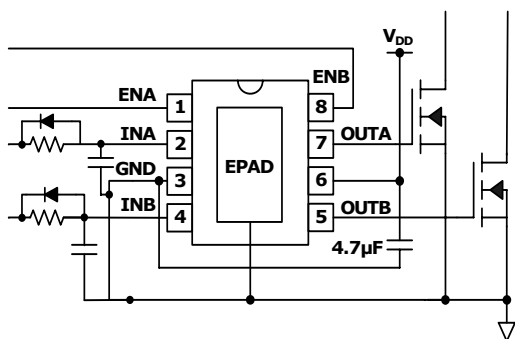
## Applications

- Synchronous Rectifier (SR) Driver
- Switch mode power supplies
- Motor Drives, Class D amplifiers, UPS, Inverters
- Pulse Transformer driver
- Clock/Line driver

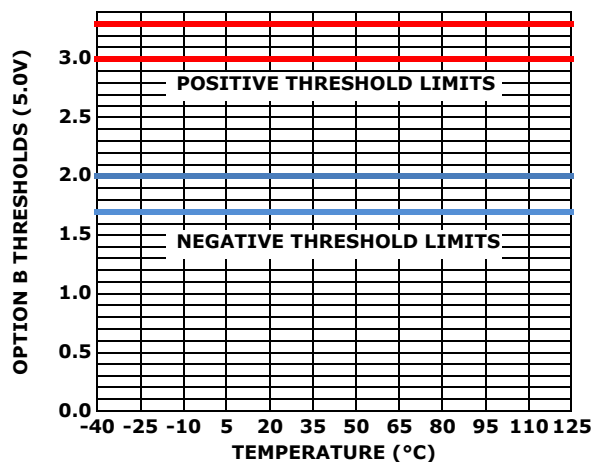
## Related Literature

- [AN1602](#) "ISL8916xA, ISL8916xB, ISL8916xC, Evaluation Board User's Guide"
- [AN1603](#) "ISL6752\_54 Evaluation Board Application Note"

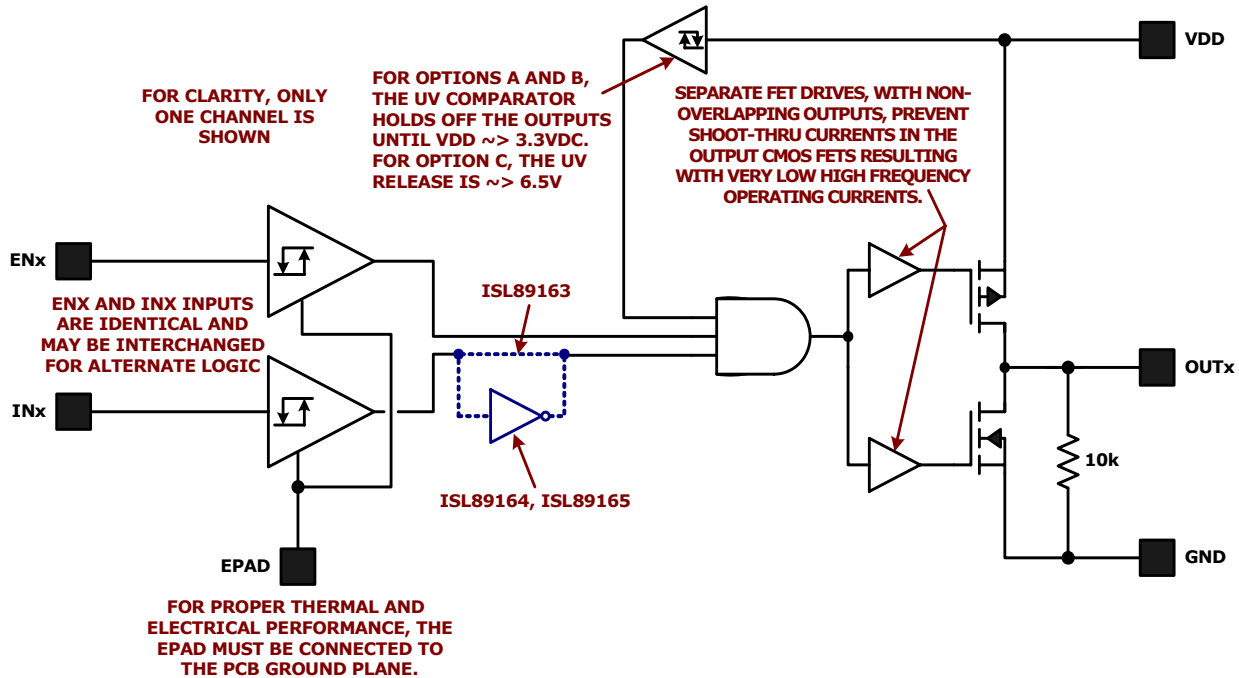
## Typical Application



## Temp Stable Logic Thresholds

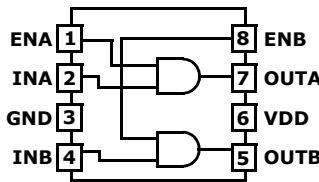


## Block Diagram

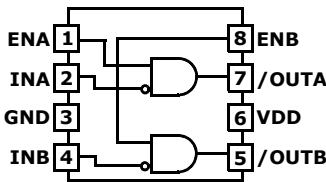


## Pin Configurations

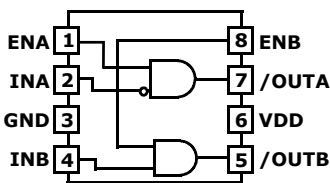
ISL89163FR, ISL89163FB  
(8 LD TDFN, EPSONIC)  
TOP VIEW



ISL89164FR, ISL89164FB  
(8 LD TDFN, EPSONIC)  
TOP VIEW



ISL89165FR, ISL89165FB  
(8 LD TDFN, EPSONIC)  
TOP VIEW



## Pin Descriptions

| PIN NUMBER | SYMBOL      | DESCRIPTION<br>(See Truth Table for Logic Polarities) |
|------------|-------------|-------------------------------------------------------|
| 1          | ENA         | Channel A enable, 0V to VDD                           |
| 2          | INA         | Channel A input, 0V to VDD                            |
| 3          | GND         | Power Ground, 0V                                      |
| 4          | INB         | Channel B enable, 0V to VDD                           |
| 5          | OUTB, /OUTB | Channel B output                                      |
| 6          | VDD         | Power input, 4.5V to 16V                              |
| 7          | OUTA, /OUTA | Channel A output, 0V to VDD                           |
| 8          | ENB         | Channel B enable, 0V to VDD                           |
|            | EPAD        | Power Ground, 0V                                      |



NON-INVERTING

| ENx* | INx* | OUTx* |
|------|------|-------|
| 0    | 0    | 0     |
| 0    | 1    | 0     |
| 1    | 0    | 0     |
| 1    | 1    | 1     |

INVERTING

| ENx* | INx* | OUTx* |
|------|------|-------|
| 0    | 0    | 0     |
| 0    | 1    | 0     |
| 1    | 0    | 1     |
| 1    | 1    | 0     |

\*SUBSTITUTE A OR B FOR x

## Ordering Information

| PART NUMBER<br>(Notes 1, 2, 3, 4) | PART<br>MARKING | TEMP RANGE<br>(°C) | INPUT<br>CONFIGURATION    | INPUT LOGIC | PACKAGE<br>(Pb-Free) | PKG.<br>DWG. # |
|-----------------------------------|-----------------|--------------------|---------------------------|-------------|----------------------|----------------|
| ISL89163FRT <b>A</b> Z            | 163A            | -40 to +125        | non-inverting             | 3.3V        | 8 Ld 3x3 TDFN        | L8.3x3I        |
| ISL89163FRT <b>B</b> Z            | 163B            | -40 to +125        |                           | 5.0V        | 8 Ld 3x3 TDFN        | L8.3x3I        |
| ISL89163FRT <b>C</b> Z            | 163C            | -40 to +125        |                           | VDD         | 8 Ld 3x3 TDFN        | L8.3x3I        |
| ISL89164FRT <b>A</b> Z            | 164A            | -40 to +125        | inverting                 | 3.3V        | 8 Ld 3x3 TDFN        | L8.3x3I        |
| ISL89164FRT <b>B</b> Z            | 164B            | -40 to +125        |                           | 5.0V        | 8 Ld 3x3 TDFN        | L8.3x3I        |
| ISL89164FRT <b>C</b> Z            | 164C            | -40 to +125        |                           | VDD         | 8 Ld 3x3 TDFN        | L8.3x3I        |
| ISL89165FRT <b>A</b> Z            | 165A            | -40 to +125        | inverting + non-inverting | 3.3V        | 8 Ld 3x3 TDFN        | L8.3x3I        |
| ISL89165FRT <b>B</b> Z            | 165B            | -40 to +125        |                           | 5.0V        | 8 Ld 3x3 TDFN        | L8.3x3I        |
| ISL89165FRT <b>C</b> Z            | 165C            | -40 to +125        |                           | VDD         | 8 Ld 3x3 TDFN        | L8.3x3I        |
| ISL89163FBE <b>A</b> Z            | 89163 FBEAZ     | -40 to +125        | non-inverting             | 3.3V        | 8 Ld EPSONIC         | M8.15D         |
| ISL89163FBE <b>B</b> Z            | 89163 FBEBZ     | -40 to +125        |                           | 5.0V        | 8 Ld EPSONIC         | M8.15D         |
| ISL89163FBE <b>C</b> Z            | 89163 FBECZ     | -40 to +125        |                           | VDD         | 8 Ld EPSONIC         | M8.15D         |
| ISL89164FBE <b>A</b> Z            | 89164 FBEAZ     | -40 to +125        | inverting                 | 3.3V        | 8 Ld EPSONIC         | M8.15D         |
| ISL89164FBE <b>B</b> Z            | 89164 FBEBZ     | -40 to +125        |                           | 5.0V        | 8 Ld EPSONIC         | M8.15D         |
| ISL89164FBE <b>C</b> Z            | 89164 FBECZ     | -40 to +125        |                           | VDD         | 8 Ld EPSONIC         | M8.15D         |
| ISL89165FBE <b>A</b> Z            | 89165 FBEAZ     | -40 to +125        | inverting + non-inverting | 3.3V        | 8 Ld EPSONIC         | M8.15D         |
| ISL89165FBE <b>B</b> Z            | 89165 FBEBZ     | -40 to +125        |                           | 5.0V        | 8 Ld EPSONIC         | M8.15D         |
| ISL89165FBE <b>C</b> Z            | 89165 FBECZ     | -40 to +125        |                           | VDD         | 8 Ld EPSONIC         | M8.15D         |

### NOTES:

1. Add "-T", suffix for tape and reel. Please refer to [TB347](#) for details on reel specifications.
2. These Intersil Pb-free plastic packaged products employ special Pb-free material sets, molding compounds/die attach materials, and 100% matte tin plate plus anneal (e3 termination finish, which is RoHS compliant and compatible with both SnPb and Pb-free soldering operations). Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.
3. Input Logic Voltage: A = 3.3V, B = 5.0V, C = VDD.
4. For Moisture Sensitivity Level (MSL), please see device information page for [ISL89163](#), [ISL89164](#), [ISL89165](#). For more information on MSL, please see Technical Brief [TB363](#).

# ISL89163, ISL89164, ISL89165

## Absolute Maximum Ratings

Supply Voltage,  $V_{DD}$  Relative to GND . . . . . -0.3V to 18V  
 Logic Inputs (INA, INB, ENA, ENB) GND - 0.3V to  $V_{DD}$  + 0.3V  
 Outputs (OUTA, OUTB) . . . . . GND - 0.3V to  $V_{DD}$  + 0.3V  
 Average Output Current (Note 7) . . . . . 150mA

## ESD Ratings

Human Body Model Class 2 (Tested per JESD22-A114E) 2000V  
 Machine Model Class B (Tested per JESD22-A115-A) . . . 200V  
 Charged Device Model Class IV . . . . . 1000V

## Latch-Up

(Tested per JESD-78B; Class 2, Level A)  
 Output Current . . . . . 500 mA

## Thermal Information

Thermal Resistance (Typical)  $\theta_{JA}$  (°C/W)  $\theta_{JC}$  (°C/W)  
 8 Ld TDFN Package (Notes 5, 6) . . . 44 3  
 8 Ld EPSON Package (Notes 5, 6) . . . 42 3  
 Max Power Dissipation at +25°C in Free Air . . . . . 2.27W  
 Max Power Dissipation at +25°C with Copper Plane . . . 33.3W  
 Storage Temperature Range . . . . . -65°C to +150°C  
 Operating Junction Temp Range . . . . . -40°C to +125°C  
 Pb-Free Reflow Profile . . . . . see link below  
<http://www.intersil.com/pbfree/Pb-FreeReflow.asp>

## Maximum Recommended Operating Conditions

Junction Temperature . . . . . -40°C to +125°C  
**Options A and B**  
 Supply Voltage,  $V_{DD}$  Relative to GND . . . . . 4.5V to 16V  
 Logic Inputs (INA, INB, ENA, ENB) . . . . . 0V to  $V_{DD}$   
 Outputs (OUTA, OUTB) . . . . . 0V to  $V_{DD}$   
**Option C**  
 Supply Voltage,  $V_{DD}$  Relative to GND . . . . . 7.5V to 16V  
 Logic Inputs (INA, INB, ENA, ENB) . . . . . 0V to  $V_{DD}$   
 Outputs (OUTA, OUTB) . . . . . 0V to  $V_{DD}$

**CAUTION:** Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions may adversely impact product reliability and result in failures not covered by warranty.

## NOTES:

- $\theta_{JA}$  is measured in free air with the component mounted on a high effective thermal conductivity test board with "direct attach" features. See Tech Brief TB379 for details.
- For  $\theta_{JC}$ , the "case temp" location is the center of the exposed metal pad on the package underside.
- The average output current, when driving a power MOSFET or similar capacitive load, is the average of the rectified output current. The peak output currents of this driver are self limiting by transconductance or  $r_{DS(ON)}$  and do not required any external components to minimize the peaks. If the output is driving a non-capacitive load, such as an LED, maximum output current must be limited by external means to less than the specified absolute maximum.

## DC Electrical Specifications

$V_{DD} = 12V$ , GND = 0V, No load on OUTA or OUTB, unless otherwise specified.  
**Boldface limits apply over the operating junction temperature range, -40°C to +125°C.**

| PARAMETERS                                          | SYMBOL          | TEST CONDITIONS                               | T <sub>J</sub> = +25°C |       |     | T <sub>J</sub> = -40°C to +125°C |              | UNITS |
|-----------------------------------------------------|-----------------|-----------------------------------------------|------------------------|-------|-----|----------------------------------|--------------|-------|
|                                                     |                 |                                               | MIN                    | TYP   | MAX | MIN (Note 8)                     | MAX (Note 8) |       |
| POWER SUPPLY                                        |                 |                                               |                        |       |     |                                  |              |       |
| Voltage Range (Option A and B)                      | V <sub>DD</sub> |                                               | -                      | -     | -   | 4.5                              | 16           | V     |
| Voltage Range (Option C)                            | V <sub>DD</sub> |                                               | -                      | -     | -   | 7.5                              | 16           | V     |
| V <sub>DD</sub> Quiescent Current                   | I <sub>DD</sub> | ENx = INx = GND                               | -                      | 5     | -   | -                                | -            | mA    |
|                                                     |                 | INA = INB = 1MHz, square wave                 | -                      | 25    |     | -                                | -            | mA    |
| UNDERVOLTAGE                                        |                 |                                               |                        |       |     |                                  |              |       |
| VDD Undervoltage Lock-out (Option A or B) (Note 12) | V <sub>UV</sub> | ENA = ENB = True<br>INA = INB = True (Note 9) | -                      | 3.3   | -   | -                                | -            | V     |
| VDD Undervoltage Lock-out (Option C)                | V <sub>UV</sub> |                                               | -                      | 6.5   | -   | -                                | -            | V     |
| Hysteresis (Option A or B)                          |                 |                                               | -                      | ~25   | -   | -                                | -            | mV    |
| Hysteresis (Option C)                               |                 |                                               | -                      | ~0.95 | -   | -                                | -            | V     |

# ISL89163, ISL89164, ISL89165

**DC Electrical Specifications**  $V_{DD} = 12V$ ,  $GND = 0V$ , No load on OUTA or OUTB, unless otherwise specified.  
**Boldface limits apply over the operating junction temperature range, -40°C to +125°C. (Continued)**

| PARAMETERS                                               | SYMBOL                               | TEST CONDITIONS                                         | T <sub>J</sub> = +25°C |      |     | T <sub>J</sub> = -40°C to +125°C |                 | UNITS |
|----------------------------------------------------------|--------------------------------------|---------------------------------------------------------|------------------------|------|-----|----------------------------------|-----------------|-------|
|                                                          |                                      |                                                         | MIN                    | TYP  | MAX | MIN<br>(Note 8)                  | MAX<br>(Note 8) |       |
| INPUTS                                                   |                                      |                                                         |                        |      |     |                                  |                 |       |
| Input Range for INA, INB                                 | V <sub>IN</sub>                      | Option A, B, or C                                       | -                      | -    | -   | GND                              | V <sub>DD</sub> | V     |
| Logic 0 Threshold<br>for INA, INB, ENA, ENB<br>(Note 11) | V <sub>IL</sub>                      | Option A, nominally 37% x 3.3V                          | -                      | 1.22 | -   | 1.12                             | 1.32            | V     |
|                                                          |                                      | Option B, nominally 37% x 5.0V                          | -                      | 1.85 | -   | 1.70                             | 2.00            | V     |
|                                                          |                                      | Option C, nominally 20% x 12V<br>(Note 9)               | -                      | 2.4  | -   | 2.00                             | 2.76            | V     |
| Logic 1 Threshold<br>for INA, INB, ENA, ENB<br>(Note 11) | V <sub>IH</sub>                      | Option A, nominally 63% x 3.3V                          | -                      | 2.08 | -   | 1.98                             | 2.18            | V     |
|                                                          |                                      | Option B, nominally 63% x 5.0V                          | -                      | 3.15 | -   | 3.00                             | 3.30            | V     |
|                                                          |                                      | Option C, nominally 80% x12V<br>(Note 9)                | -                      | 9.6  | -   | 9.24                             | 9.96            | V     |
| Input Capacitance of INA,<br>INB, ENA, ENB (Note 10)     | C <sub>IN</sub>                      |                                                         | -                      | 2    | -   | -                                | -               | pF    |
| Input Bias Current<br>for INA, INB, ENA, ENB             | I <sub>IN</sub>                      | GND<V <sub>IN</sub> <V <sub>DD</sub>                    | -                      | -    | -   | -10                              | +10             | μA    |
| OUTPUTS                                                  |                                      |                                                         |                        |      |     |                                  |                 |       |
| High Level Output Voltage                                | V <sub>OHA</sub><br>V <sub>OHB</sub> |                                                         | -                      | -    | -   | V <sub>DD</sub> - 0.1            | V <sub>DD</sub> | V     |
| Low Level Output Voltage                                 | V <sub>OLA</sub><br>V <sub>OLB</sub> |                                                         | -                      | -    | -   | GND                              | GND + 0.1       | V     |
| Peak Output Source<br>Current                            | I <sub>O</sub>                       | V <sub>O</sub> (initial) = 0V, C <sub>LOAD</sub> = 10nF | -                      | -6   | -   | -                                | -               | A     |
| Peak Output Sink Current                                 | I <sub>O</sub>                       | V <sub>O</sub> (initial) =12V, C <sub>LOAD</sub> = 10nF | -                      | +6   | -   | -                                | -               | A     |

## NOTES:

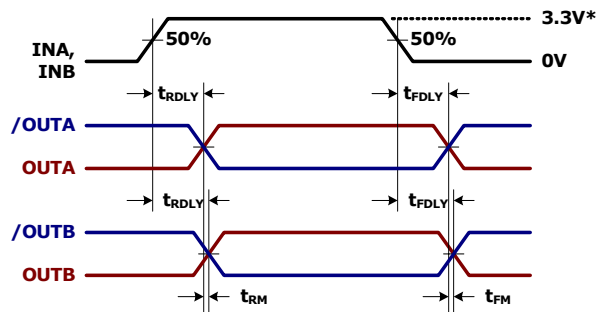
- Parameters with MIN and/or MAX limits are 100% tested at +25°C, unless otherwise specified. Temperature limits established by characterization and are not production tested.
- The nominal 20% and 80% thresholds for option C are valid for any value of  $V_{DD}$ .
- This parameter is taken from the simulation models for the input FET. The actual capacitance on this input will be dominated by the PCB parasitic capacitance.
- The true state input voltage for the non-inverted inputs is greater than the Logic 1 threshold voltage. The true state input voltage for the inverted inputs is less than the logic 0 threshold voltage.
- A 200 $\mu s$  delay further inhibits the release of the output state when the UV positive going threshold is crossed.

# ISL89163, ISL89164, ISL89165

**AC Electrical Specifications**  $V_{DD} = 12V$ ,  $GND = 0V$ , No Load on OUTA or OUTB, Unless Otherwise Specified. **Boldface limits apply over the operating junction temperature range, -40°C to +125°C.**

| PARAMETERS                                                                     | SYMBOL      | TEST CONDITIONS /NOTES                  | $T_J = +25^{\circ}C$ |      |     | $T_J = -40^{\circ}C \text{ to } +125^{\circ}C$ |           | UNITS |
|--------------------------------------------------------------------------------|-------------|-----------------------------------------|----------------------|------|-----|------------------------------------------------|-----------|-------|
|                                                                                |             |                                         | MIN                  | TYP  | MAX | MIN                                            | MAX       |       |
| Output Rise Time (see Figure 2)                                                | $t_R$       | $C_{LOAD} = 10 \text{ nF}$ , 10% to 90% | -                    | 20   | -   | -                                              | <b>40</b> | ns    |
| Output Fall Time (see Figure 2)                                                | $t_F$       | $C_{LOAD} = 10 \text{ nF}$ , 90% to 10% | -                    | 20   | -   | -                                              | <b>40</b> | ns    |
| Output Rising Edge Propagation Delay for Non-Inverting Inputs (see Figure 1)   | $t_{RDLYn}$ | No load                                 | -                    | 25   | -   | -                                              | <b>50</b> | ns    |
| Output Rising Edge Propagation Delay with Inverting Inputs (see Figure 1)      | $t_{RDLYi}$ | No load                                 | -                    | 25   | -   | -                                              | <b>50</b> | ns    |
| Output Falling Edge Propagation Delay with Non-Inverting Inputs (see Figure 1) | $t_{FDLYn}$ | No load                                 | -                    | 25   | -   | -                                              | <b>50</b> | ns    |
| Output Falling Edge Propagation Delay with Inverting Inputs (see Figure 1)     | $t_{FDLYi}$ | No load                                 | -                    | 25   | -   | -                                              | <b>50</b> | ns    |
| Rising Propagation Matching (see Figure 1)                                     | $t_{RM}$    |                                         | -                    | <1ns | -   | -                                              | -         | ns    |
| Falling Propagation Matching (see Figure 1)                                    | $t_{FM}$    |                                         | -                    | <1ns | -   | -                                              | -         | ns    |
| Miller Plateau Sink Current (See Test Circuit Figure 3)                        | $-I_{MP}$   | $V_{DD} = 10V$ , $V_{MILLER} = 5V$      | -                    | 6    | -   | -                                              | -         | A     |
|                                                                                | $-I_{MP}$   | $V_{DD} = 10V$ , $V_{MILLER} = 3V$      | -                    | 4.7  | -   | -                                              | -         | A     |
|                                                                                | $-I_{MP}$   | $V_{DD} = 10V$ , $V_{MILLER} = 2V$      | -                    | 3.7  | -   | -                                              | -         | A     |
| Miller Plateau Source Current (See Test Circuit Figure 4)                      | $I_{MP}$    | $V_{DD} = 10V$ , $V_{MILLER} = 5V$      | -                    | 5.2  | -   | -                                              | -         | A     |
|                                                                                | $I_{MP}$    | $V_{DD} = 10V$ , $V_{MILLER} = 3V$      | -                    | 5.8  | -   | -                                              | -         | A     |
|                                                                                | $I_{MP}$    | $V_{DD} = 10V$ , $V_{MILLER} = 2V$      | -                    | 6.9  | -   | -                                              | -         | A     |

## Test Waveforms and Circuits



\* LOGIC LEVELS: A OPTION = 3.3V, B OPTION = 5.0V,  
C OPTION = VDD

FIGURE 1. PROP DELAYS AND MATCHING

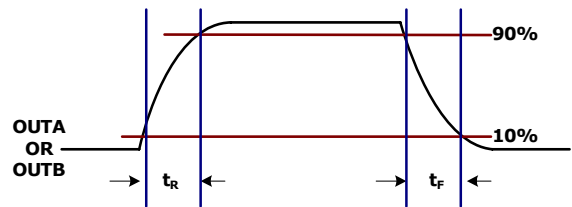


FIGURE 2. RISE/FALL TIMES

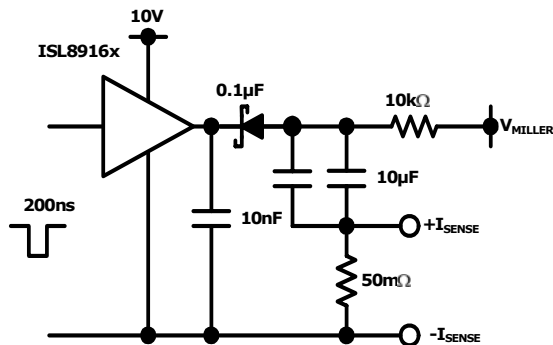


FIGURE 3. MILLER PLATEAU SINK CURRENT TEST CIRCUIT

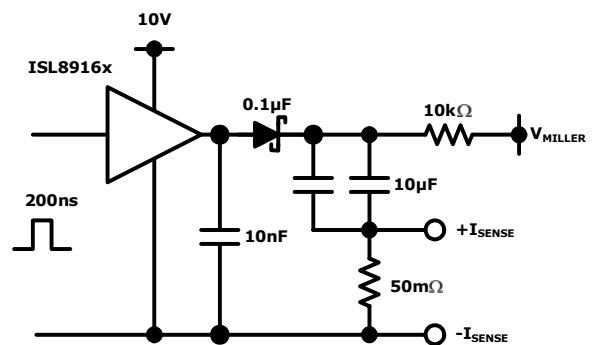


FIGURE 4. MILLER PLATEAU SOURCE CURRENT TEST CIRCUIT

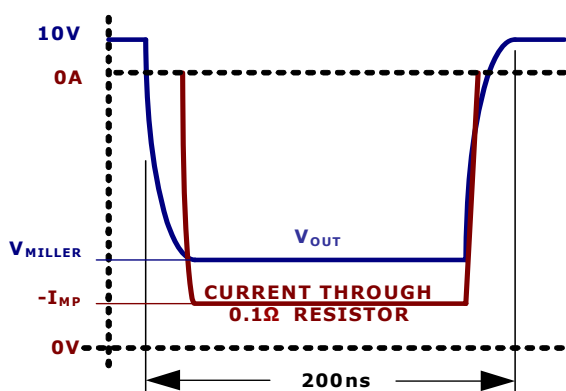


FIGURE 5. MILLER PLATEAU SINK CURRENT

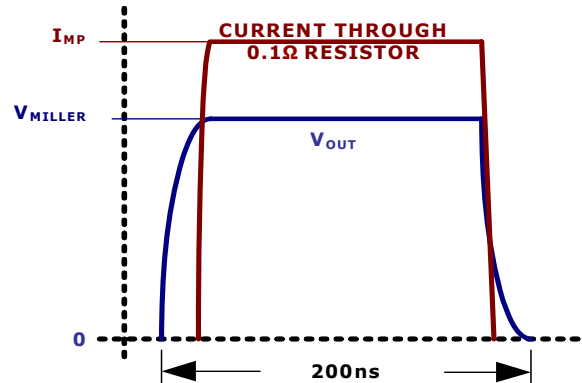


FIGURE 6. MILLER PLATEAU SOURCE CURRENT

## Typical Performance Curves

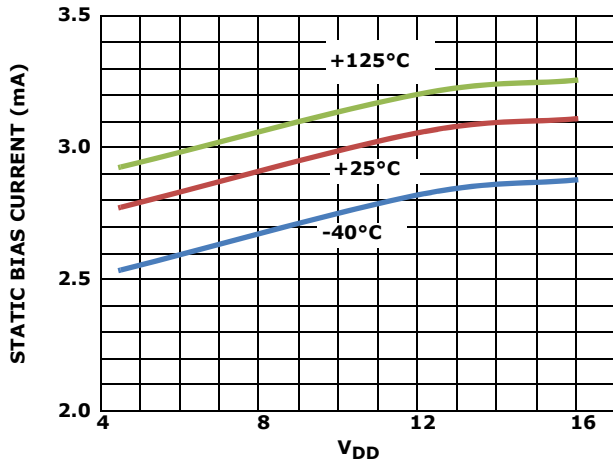


FIGURE 7.  $I_{DD}$  vs  $V_{DD}$  (STATIC)

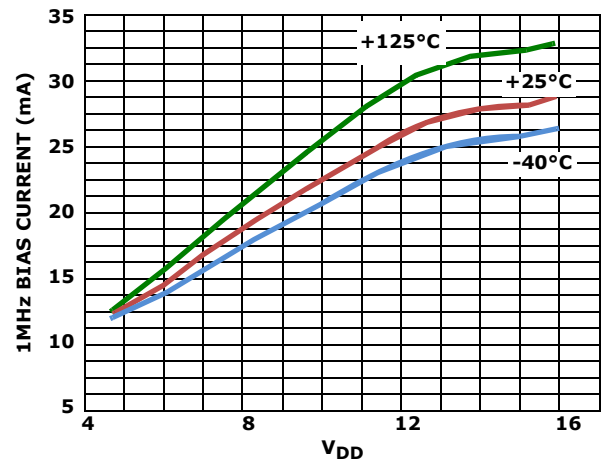


FIGURE 8.  $I_{DD}$  vs  $V_{DD}$  (1 MHz)

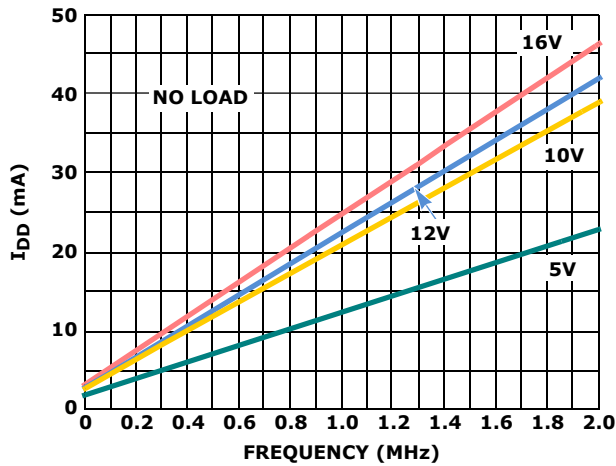


FIGURE 9.  $I_{DD}$  vs FREQUENCY (+25°C)

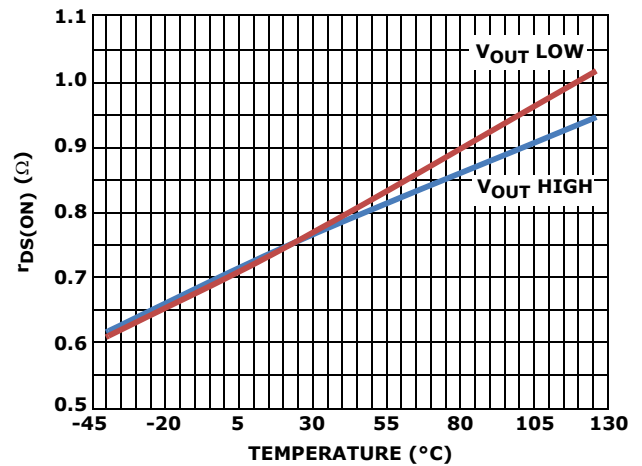


FIGURE 10.  $r_{DS(on)}$  vs TEMPERATURE

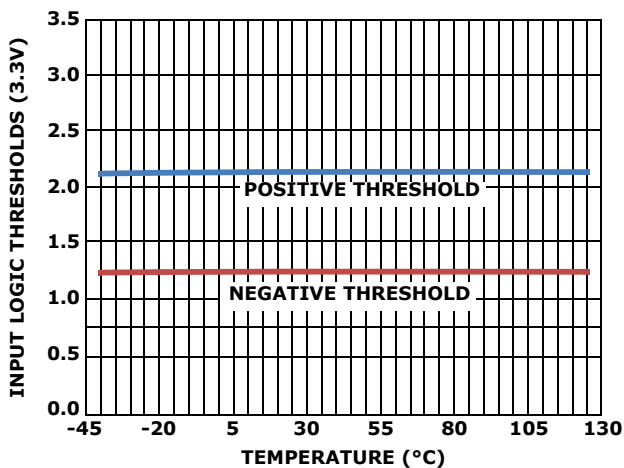


FIGURE 11. OPTION A THRESHOLDS

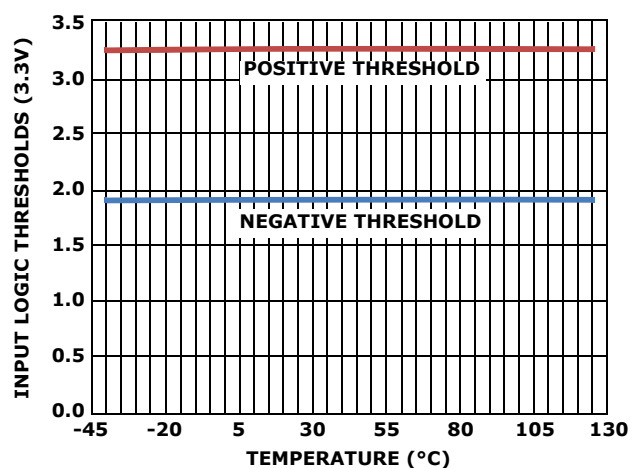


FIGURE 12. OPTION B THRESHOLDS

## Typical Performance Curves (Continued)

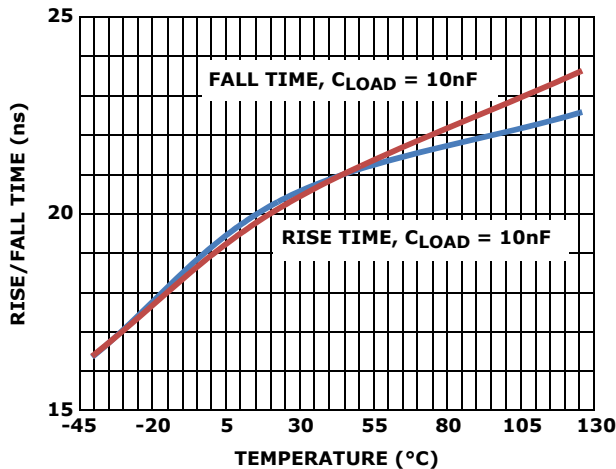


FIGURE 13. OUTPUT RISE/FALL TIME

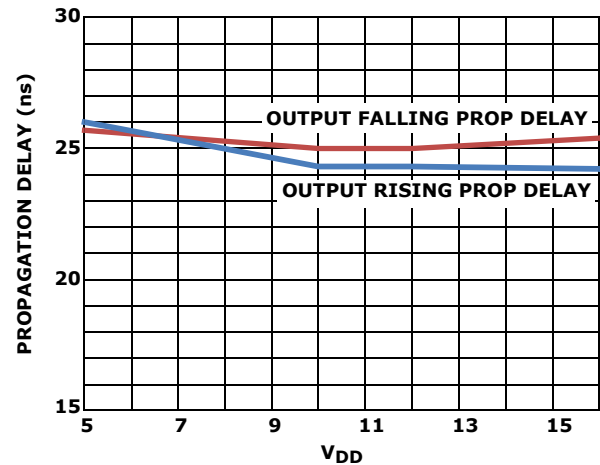


FIGURE 14. PROPAGATION DELAY vs  $V_{DD}$

## Functional Description

### Overview

The ISL89163, ISL89164, ISL89165 MOSFET drivers incorporate several features optimized for Synchronous Rectifier (SR) driver applications including precision input logic thresholds, enable inputs, undervoltage lock-out, and high output drive currents.

The precision input thresholds facilitate the use of an external RC network to delay the rising or falling propagation of the driver output. This is a useful feature for adjusting when the SRs turn-on relative to the primary side FETs. In a similar manner, these drivers can also be used to control the turn-on/off timing of the primary FETs.

The Enable inputs (ENA, ENB) are used to emulate diode operation of the SRs by disabling the driver output when it is necessary to prevent negative currents in the SRs. An example is turning off the SRs when the power supply output is turned off. This prevents the output capacitor from being discharged through the output inductor. If this is allowed to happen, the voltage across the output capacitor will ring negative possibly damaging the capacitor (if it is polarized) and probably damaging the load. Another example is preventing circulating currents between paralleled power supplies during no or light load conditions. During light load conditions (especially when active load sharing is not active), energy will be transferred from the paralleled power supply that has a higher voltage to the paralleled power supply with the lower voltage. Consequently, the energy that is absorbed by the low voltage output is then transferred to the primary side causing the bus voltage to increase until the primary side is damaged by excessive voltage.

To prevent unexpected glitches on the output of the ISL89163, ISL89164, ISL89165 during power-on or power-off when  $V_{DD}$  is very low, the Undervoltage (UV) lock-out prevents the outputs of the ISL89163,

ISL89164, ISL89165 driver from turning on. The A and B input threshold options force the driver outputs to be low when  $V_{DD} < \sim 3.2$  VDC regardless of the input logic states. The C option shuts down when  $V_{DD} < \sim 6.5$  VDC.

## Application Information

### Precision Thresholds for Time Delays

Three input logic voltage levels are supported by the ISL89163, ISL89164, ISL89165. Option A is used for 3.3V logic, Option B is used for 5.0V logic, and Option C is used for higher voltage logic when it is desired to have voltage thresholds that are proportional to  $V_{DD}$ . The A and B options have nominal thresholds that are 37% and 63% of 3.3V and 5.0V respectively and the C option is 20% and 80% of  $V_{DD}$ .

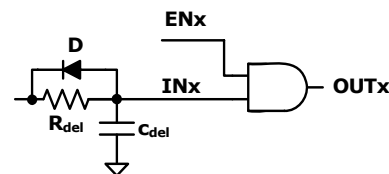


FIGURE 15. DELAY USING RCD NETWORK

In Figure 15,  $R_{del}$  and  $C_{del}$  delay the rising edge of the input signal. For the falling edge of the input signal, the Diode shorts out the resistor resulting in a minimal falling edge delay.

The 37% and 63% thresholds of options A and B were chosen to simplify the calculations for the desired time delays. When using an RC circuit to generate a time delay, the delay is simply  $T \text{ (secs)} = R \text{ (ohms)} \times C \text{ (farads)}$ . Please note that this equation only applies if the input logic voltage is matched to the 3.3V or 5V threshold options. If the logic high amplitude is not equal to 3.3V or 5V, then the equations in Equation 1 can be used for more precise delay calculations.

$$\begin{aligned}
 V_H &= 10V && \text{High level of the logic signal into the RC} \\
 V_{thres} &= 63\% \times 5V && \text{Positive going threshold for 5V logic (B option)} \\
 V_L &= .3V && \text{Low level of the logic signal into the RC} \\
 R_{del} &= 100\Omega && \text{Timing values} \\
 C_{del} &= 1nF \\
 t_{del} &= -R_{del} C_{del} \times \ln \left( \frac{V_L - V_{thres}}{V_H - V_L} + 1 \right) \\
 t_{del} &= 34.788 \text{ ns} && \text{nominal delay time for this example}
 \end{aligned}
 \tag{EQ. 1}$$

In this example, the high logic voltage is 10V, the positive threshold is 63% of 5V and the low level logic is 0.3V. Note the the rising edge propagation delay of the driver must be added to this value.

The minimum recommended value of C is 100pF. The parasitic capacitance of the PCB and any attached scope probes will introduce significant delay errors if smaller values are used. Larger values of C will further minimize errors.

Acceptable values of R are primarily effected by the source resistance of the logic inputs. Generally, 100Ω resistors or larger are usable.

### Power Dissipation of the Driver

The power dissipation of the ISL89163, ISL89164, ISL89165 is dominated by the losses associated with the gate charge of the driven bridge FETs and the switching frequency. The internal bias current also contributes to the total dissipation but is usually not significant as compared to the gate charge losses.

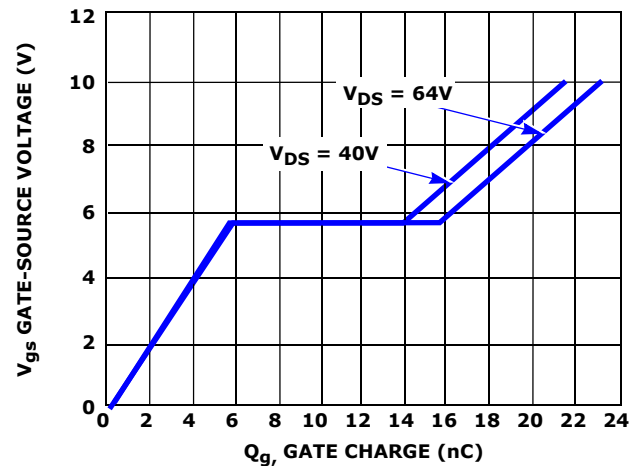


FIGURE 16. MOSFET GATE CHARGE vs GATE VOLTAGE

Figure 16 illustrates how the gate charge varies with the gate voltage in a typical power MOSFET. In this example, the total gate charge for  $V_{GS} = 10V$  is 21.5nC when  $V_{DS} = 40V$ . This is the charge that a driver must source to turn-on the MOSFET and must sink to turn-off the MOSFET.

Equation 2 shows calculating the power dissipation of the driver:

$$P_D = 2 \cdot Q_C \cdot \text{freq} \cdot V_{GS} \cdot \frac{R_{gate}}{R_{gate} + r_{DS(ON)}} + I_{DD}(\text{freq}) \cdot V_{DD}
 \tag{EQ. 2}$$

where:

freq = Switching frequency,

$V_{GS} = V_{DD}$  bias of the ISL89163, ISL89164, ISL89165

$Q_C$  = Gate charge for  $V_{GS}$

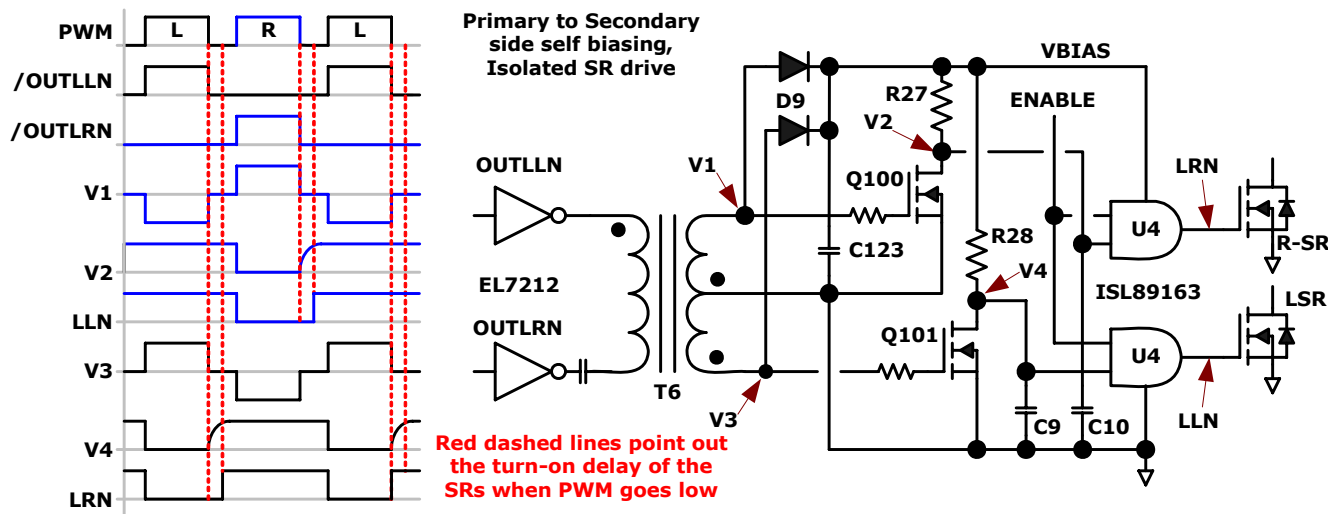
$I_{DD}(\text{freq})$  = Bias current at the switching frequency (see Figure 7)

$r_{DS(ON)}$  = ON-resistance of the driver

$R_{gate}$  = External gate resistance (if any).

Note that the gate power dissipation is proportionally shared with the external gate resistor. Do not overlook the power dissipated by the external gate resistor.

## Typical Application Circuits



This drive circuit provides Primary to Secondary line isolation. A controller, on the primary side, is the source of the SR control signals OUTLLN and OUTLRN signals. The secondary side signals, V1 and V2 are rectified by the dual diode, D9, to generate the secondary side bias for U4. V1 and V3 are also inverted by Q100 and Q101 and the rising edges are delayed by R27/C10 and R28/C9 respectively to generate the SR drive signals, LRN and LLN. For more complete information on this SR drive circuit, and other applications for the ISL89163/4/5, refer to [AN1603](#) "ISL6752\_54 Evaluation Board Application Note".

## General PCB Layout Guidelines

The AC performance of the ISL89163, ISL89164, ISL89165 depends significantly on the design of the PC board. The following layout design guidelines are recommended to achieve optimum performance:

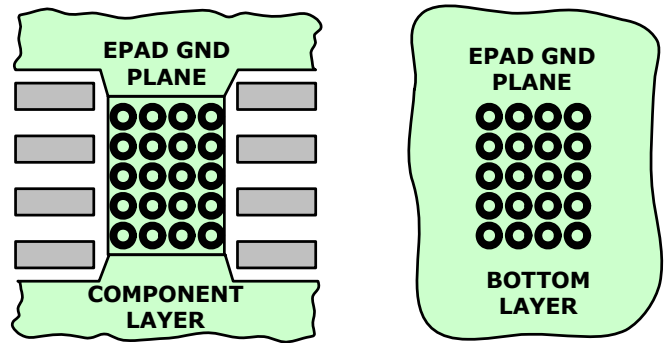
- Place the driver as close as possible to the driven power FET.
- Understand where the switching power currents flow. The high amplitude di/dt currents of the driven power FET will induce significant voltage transients on the associated traces.
- Keep power loops as short as possible by paralleling the source and return traces.
- Use planes where practical; they are usually more effective than parallel traces.
- Avoid paralleling high amplitude di/dt traces with low level signal lines. High di/dt will induce currents and consequently, noise voltages in the low level signal lines.
- When practical, minimize impedances in low level signal circuits. The noise, magnetically induced on a 10k resistor, is 10x larger than the noise on a 1k resistor.
- Be aware of magnetic fields emanating from transformers and inductors. Gaps in these structures are especially bad for emitting flux.
- If you must have traces close to magnetic devices, align the traces so that they are parallel to the flux lines to minimize coupling.
- The use of low inductance components such as chip resistors and chip capacitors is highly recommended.
- Use decoupling capacitors to reduce the influence of parasitic inductance in the VDD and GND leads. To be effective, these caps must also have the shortest possible conduction paths. If vias are used, connect several paralleled vias to reduce the inductance of the vias.
- It may be necessary to add resistance to dampen resonating parasitic circuits especially on OUTA and OUTB. If an external gate resistor is unacceptable, then the layout must be improved to minimize lead inductance.
- Keep high dv/dt nodes away from low level circuits. Guard banding can be used to shunt away dv/dt injected currents from sensitive circuits. This is especially true for control circuits that source the input signals to the ISL89163, ISL89164, ISL89165.
- Avoid having a signal ground plane under a high amplitude dv/dt circuit. This will inject di/dt currents into the signal ground paths.
- Do power dissipation and voltage drop calculations of the power traces. Many PCB/CAD programs have built in tools for calculation of trace resistance.
- Large power components (Power FETs, Electrolytic caps, power resistors, etc.) will have internal parasitic inductance which cannot be eliminated. This must be accounted for in the PCB layout and circuit design.
- If you simulate your circuits, consider including parasitic components especially parasitic inductance.

## General EPAD Heatsinking Considerations

The thermal pad is electrically connected to the GND supply through the IC substrate. The epad of the ISL89163, ISL89164, ISL89165 has two main functions: to provide a quiet Gnd for the input threshold comparators and to provide heat sinking for the IC. The EPAD must be connected to a ground plane and no switching currents from the driven FET should pass through the ground plane under the IC.

Figure 17 is a PCB layout example of how to use vias to remove heat from the IC through the EPAD.

For maximum heatsinking, it is recommended that a ground plane, connected to the EPAD, be added to both sides of the PCB. A via array, within the area of the EPAD, will conduct heat from the EPAD to the gnd plane on the bottom layer. The number of vias and the size of the gnd planes required for adequate heatsinking is determined by the power dissipated by the ISL89163, ISL89164, ISL89165, the air flow and the maximum temperature of the air around the IC.



**FIGURE 17. TYPICAL PCB PATTERN FOR THERMAL VIAS**

## Revision History

The revision history provided is for informational purposes only and is believed to be accurate, but not warranted. Please go to web to make sure you have the latest Rev.

| DATE     | REVISION | CHANGE          |
|----------|----------|-----------------|
| 10/12/10 | FN7707.0 | Initial Release |

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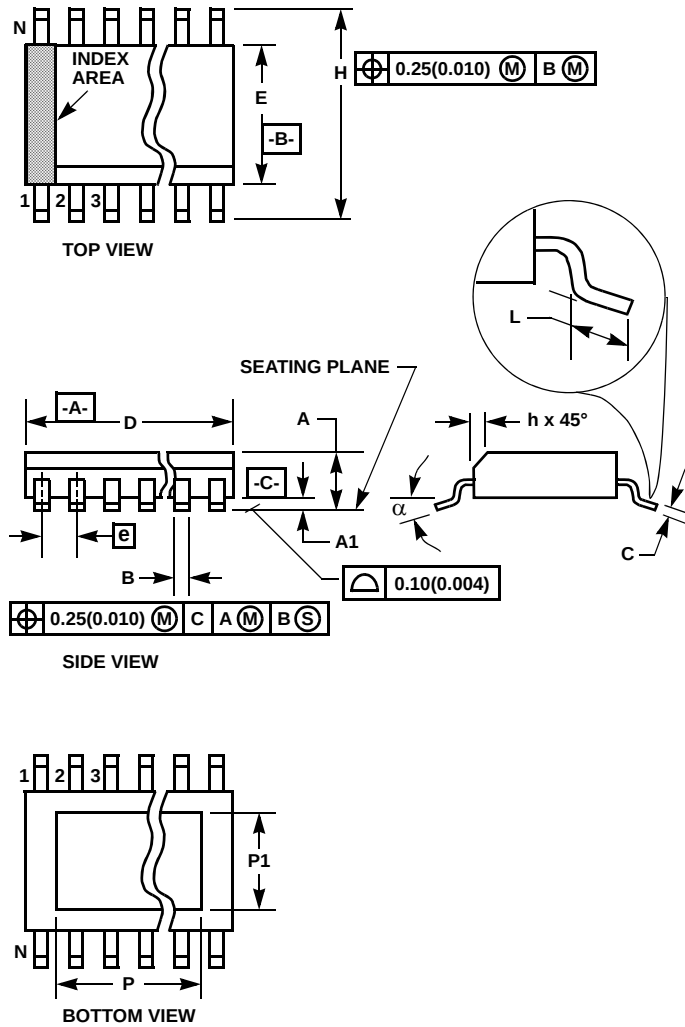
\*For a complete listing of Applications, Related Documentation and Related Parts, please see the respective device information page on intersil.com: [ISL89163, ISL89164, ISL89165](http://www.intersil.com/products)

To report errors or suggestions for this datasheet, please go to [www.intersil.com/askourstaff](http://www.intersil.com/askourstaff)

FITs are available from our website at <http://rel.intersil.com/reports/sear>



Small Outline Exposed Pad Plastic Packages (EPSOIC)



M8.15D

8 LEAD NARROW BODY SMALL OUTLINE EXPOSED PAD PLASTIC PACKAGE

| SYMBOL   | INCHES    |        | MILLIMETERS |      | NOTES |
|----------|-----------|--------|-------------|------|-------|
|          | MIN       | MAX    | MIN         | MAX  |       |
| A        | 0.059     | 0.067  | 1.52        | 1.72 | -     |
| A1       | 0.003     | 0.009  | 0.10        | 0.25 | -     |
| B        | 0.0138    | 0.0192 | 0.36        | 0.46 | 9     |
| C        | 0.0075    | 0.0098 | 0.19        | 0.25 | -     |
| D        | 0.189     | 0.196  | 4.80        | 4.98 | 3     |
| E        | 0.150     | 0.157  | 3.811       | 3.99 | 4     |
| e        | 0.050 BSC |        | 1.27 BSC    |      | -     |
| H        | 0.230     | 0.244  | 5.84        | 6.20 | -     |
| h        | 0.010     | 0.019  | 0.25        | 0.50 | 5     |
| L        | 0.016     | 0.050  | 0.41        | 1.27 | 6     |
| N        | 8         |        | 8           |      | 7     |
| $\alpha$ | 0°        | 8°     | 0°          | 8°   | -     |
| P        | 0.118     | 0.137  | 3.00        | 3.50 | 11    |
| P1       | 0.078     | 0.099  | 2.00        | 2.50 | 11    |

Rev. 0 5/07

NOTES:

1. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication Number 95.
2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
3. Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
4. Dimension "E" does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.25mm (0.010 inch) per side.
5. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
6. "L" is the length of terminal for soldering to a substrate.
7. "N" is the number of terminal positions.
8. Terminal numbers are shown for reference only.
9. The lead width "B", as measured 0.36mm (0.014 inch) or greater above the seating plane, shall not exceed a maximum value of 0.61mm (0.024 inch).
10. Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.
11. Dimensions "P" and "P1" are thermal and/or electrical enhanced variations. Values shown are maximum size of exposed pad within lead count and body size.

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